

MOS FIELD EFFECT TRANSISTOR

2SK3480

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3480 is N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Super low on-state resistance:
- $R_{DS(on)1} = 31 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 25 \text{ A})$
- $R_{\text{DS(on)2}}$ = 36 m Ω MAX. (VGs = 4.5 V, ID = 25 A)
- Low Ciss: $C_{iss} = 3600 \, pF \, TYP$.
- Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V) | Vdss | 100 | V |
|---|-------------|-------------|----|
| Gate to Source Voltage (VDS = 0 V) | Vgss | ±20 | V |
| Drain Current (DC) (Tc = 25°C) | D(DC) | ±50 | А |
| Drain Current (pulse) Note1 | D(pulse) | ±100 | А |
| Total Power Dissipation (Tc = 25°C) | P T1 | 84 | W |
| Total Power Dissipation ($T_A = 25^{\circ}C$) | P T2 | 1.5 | W |
| Channel Temperature | Tch | 150 | °C |
| Storage Temperature | Tstg | -55 to +150 | °C |
| Single Avalanche Current Note2 | las | 34 | А |
| Single Avalanche Energy ^{Note2} | Eas | 116 | mJ |
| | | | |

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

THERMAL RESISTANCE

| Channel to Case | Rth(ch-C) | 1.48 | °C/W |
|--------------------|-----------|------|------|
| Channel to Ambient | Rth(ch-A) | 83.3 | °C/W |

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|---------------------------|
| 2SK3480 | TO-220AB |
| 2SK3480-S | TO-262 |
| 2SK3480-ZJ | TO-263 |
| 2SK3480-Z | TO-220SMD ^{Note} |

Note TO-220SMD package is produced only in Japan.

(TO-220AB)



(TO-262)



(TO-263, TO-220SMD)



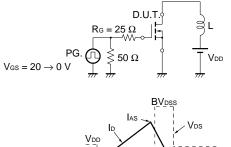
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ELECTRICAL CHARACTERISTICS (TA = 25°C)

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | IDSS | $V_{DS} = 100 V, V_{GS} = 0 V$ | | | 10 | μA |
| Gate Leakage Current | lgss | $V_{GS} = \pm 20 V, V_{DS} = 0 V$ | | | ±10 | μA |
| Gate Cut-off Voltage | V _{GS(off)} | $V_{DS} = 10 V, I_D = 1 mA$ | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | y _{fs} | $V_{DS} = 10 V, I_D = 25 A$ | 17 | 34 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | $V_{GS} = 10 V$, $I_D = 25 A$ | | 25 | 31 | mΩ |
| | RDS(on)2 | $V_{GS} = 4.5 V, I_D = 25 A$ | | 27 | 36 | mΩ |
| Input Capacitance | Ciss | V _{DS} = 10 V | | 3600 | | pF |
| Output Capacitance | Coss | V _{GS} = 0 V | | 360 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1 MHz | | 190 | | pF |
| Turn-on Delay Time | td(on) | V _{DD} = 50 V, I _D = 25 A | | 15 | | ns |
| Rise Time | tr | V _{GS} = 10 V | | 11 | | ns |
| Turn-off Delay Time | td(off) | $R_G = 0 \Omega$ | | 68 | | ns |
| Fall Time | tr | | | 6.0 | | ns |
| Total Gate Charge | QG | V _{DD} = 80 V | | 74 | | nC |
| Gate to Source Charge | QGS | Vgs = 10 V | | 10 | | nC |
| Gate to Drain Charge | Qgd | ID = 50 A | | 20 | | nC |
| Body Diode Forward Voltage | VF(S-D) | IF = 50 A, VGS = 0 V | | 1.0 | | V |
| Reverse Recovery Time | trr | IF = 50 A, VGS = 0 V | | 70 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/µs | | 180 | | nC |

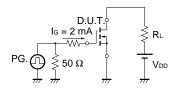
TEST CIRCUIT 1 AVALANCHE CAPABILITY

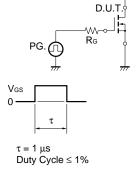
TEST CIRCUIT 2 SWITCHING TIME

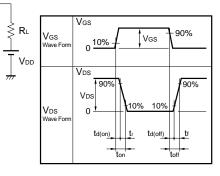




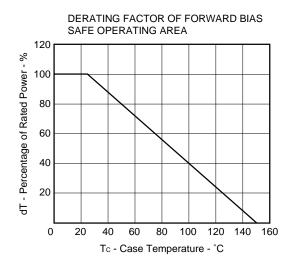
TEST CIRCUIT 3 GATE CHARGE



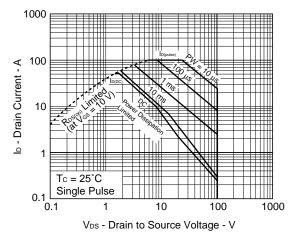


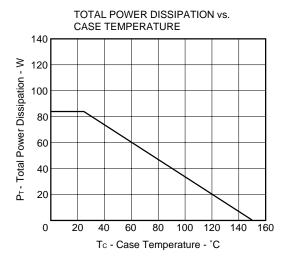


TYPICAL CHARACTERISTICS (TA = 25°C)

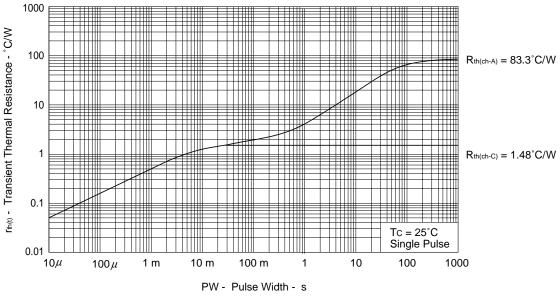


FORWARD BIAS SAFE OPERATING AREA

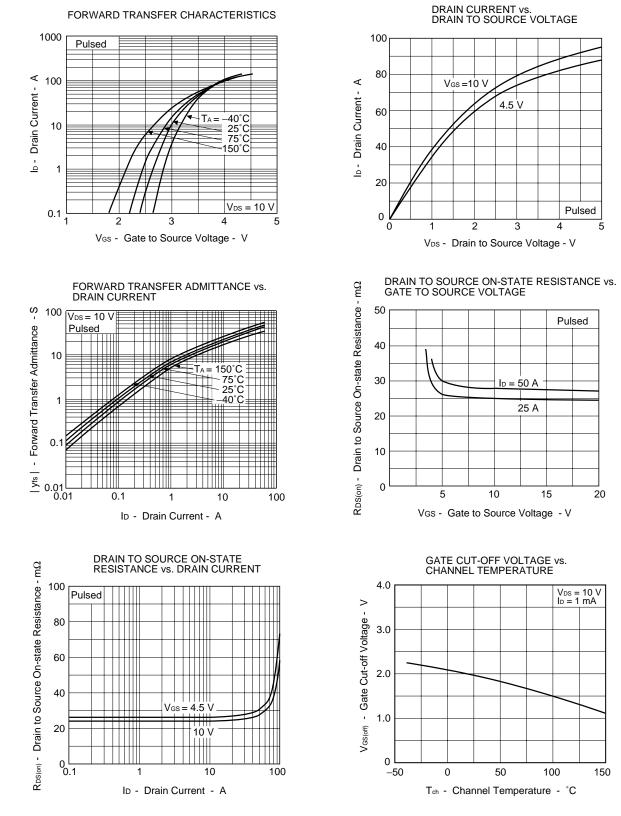




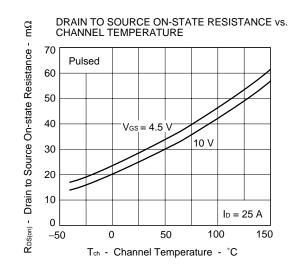
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

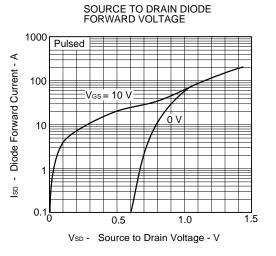


Data Sheet D15078EJ1V0DS

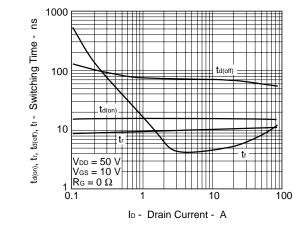


FORWARD TRANSFER CHARACTERISTICS





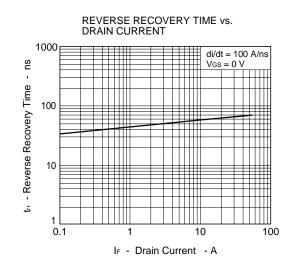
SWITCHING CHARACTERISTICS



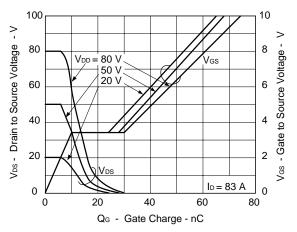
10000 <u>₽</u> Ciss, Coss, Crss - Capacitance - pF Ciss 1000 100 Vgs = 0 V f = 1 MHz10 0.01 0.1 1 10 100 VDS - Drain to Source Voltage - V

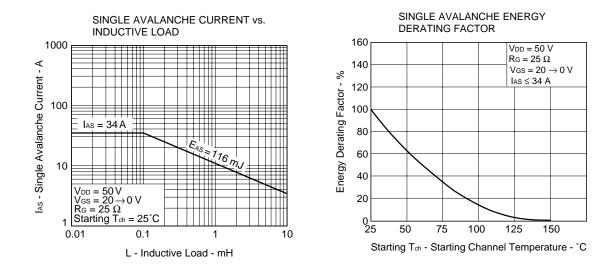
CAPACITANCE vs.

DRAIN TO SOURCE VOLTAGE



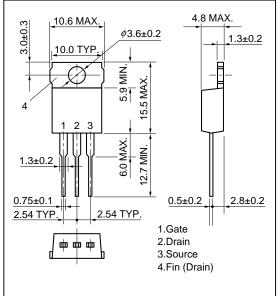
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



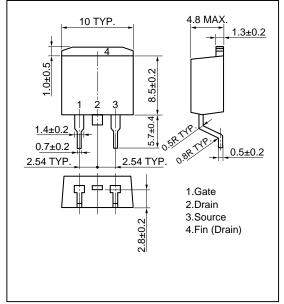


PACKAGE DRAWINGS (Unit: mm)

1) TO-220AB(MP-25)

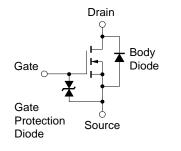


3) TO-263 (MP-25ZJ)



Remark

EQUIVALENT CIRCUIT

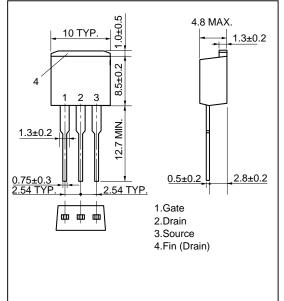


Note This package is produced only in Japan.

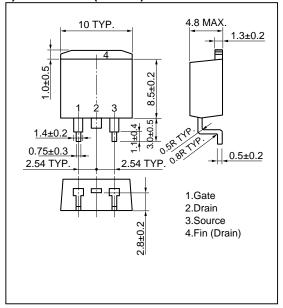
The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.



2) TO-262(MP-25 Fin Cut)



4) TO-220SMD(MP-25Z)^{Note}



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